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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/615,777	HIDAKA, HIDETO	
Examiner	Art Unit	
ANH PHUNG	2824	

	SEAR	CHED	
Class	Subclass	Date	Examiner
365	158	6/20/2005	АР
365	230.06	6/20/2005	AP
365	171	6/20/2005	AP
365	173	6/20/2005	AP
365	189.01	6/20/2005	AP
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
365	158	6/20/2005	AP
365	230.06	6/20/2005	AP

SEA (INCLUDING	ARCH NOT	ES STRATEGY)
		DATE	EXMR
EAST		6/20/2005	АР